

Engineering Optics

Lecture 34

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by

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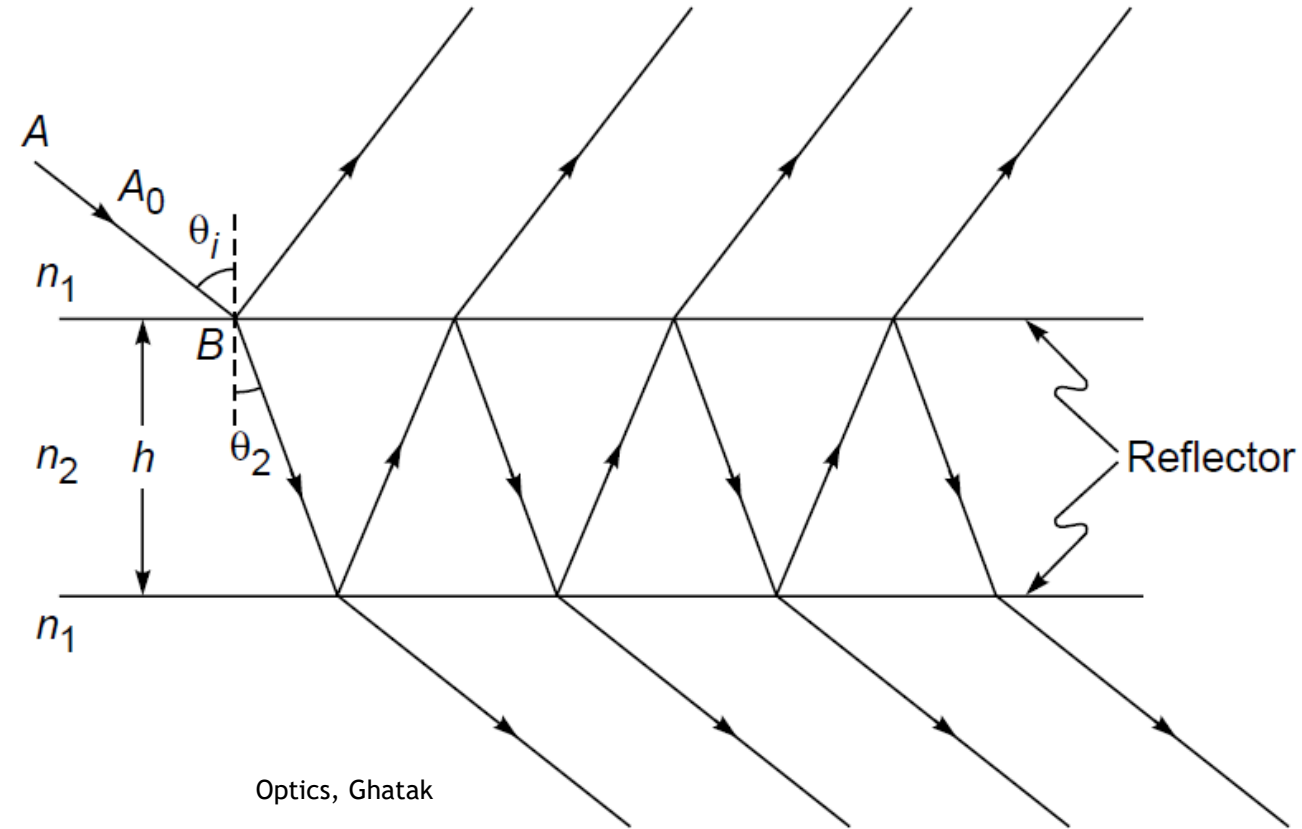
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The Fabry-Perot interferometer

Multiple reflections from a plane parallel film

We consider the incidence of a plane wave on a plate of thickness h (and of refractive index n_2) surrounded by a medium of refractive index n_1

- Let A_0 be the (complex) amplitude of the incident wave.
- The wave will undergo multiple reflections at the two interfaces
- when the wave is incident from n_1 toward n_2 :
- r_1 and t_1 represent the amplitude reflection and transmission coefficients, respectively
- When the wave is incident from n_2 toward $n_1 \rightarrow r_2$ and t_2 represent the corresponding coefficients.



Multiple reflections from a plane parallel film

- $A_0 \rightarrow$ amplitude of the incident wave.
- When the wave is from n_1 toward n_2 : r_1 , t_1
- from n_2 toward $n_1 \rightarrow r_2$ and t_2
- Thus the amplitude of the successive reflected waves will be

$$A_0 r_1, A_0 t_1 r_2 t_2 e^{i\delta}, A_0 t_1 r_2^3 e^{2i\delta}, \dots$$

where

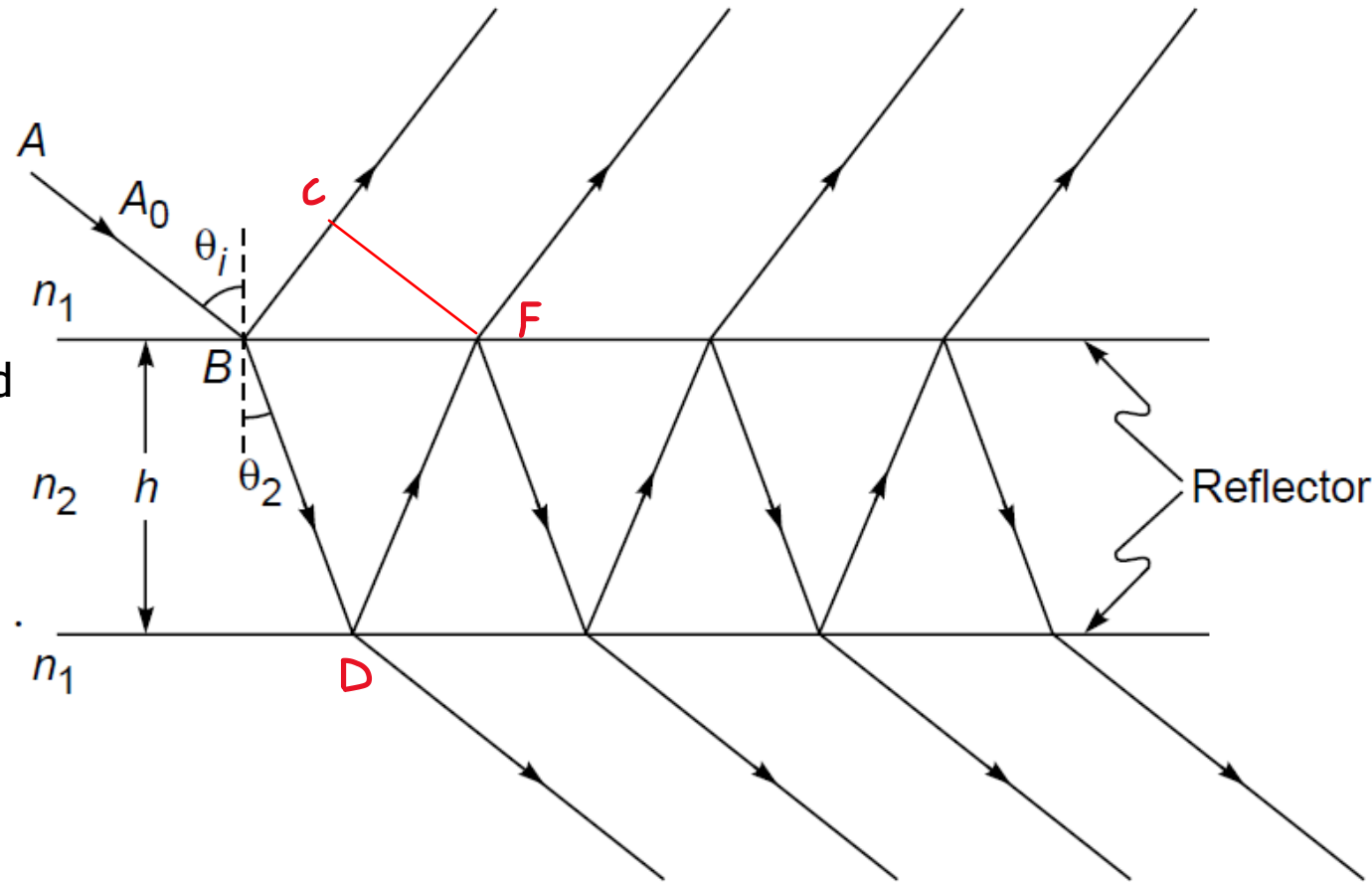
$$\delta = \frac{2\pi}{\lambda_0} \Delta = \frac{4\pi n_2 h \cos \theta_2}{\lambda_0}$$

represents the phase difference
(between two successive waves
emanating from the plate)

Extra path = $n_2(BD+DF) - n_1 BC$

Now check Δ

For the calculation see Section 15.3 “The Cosine Law”, Ghatak’s book



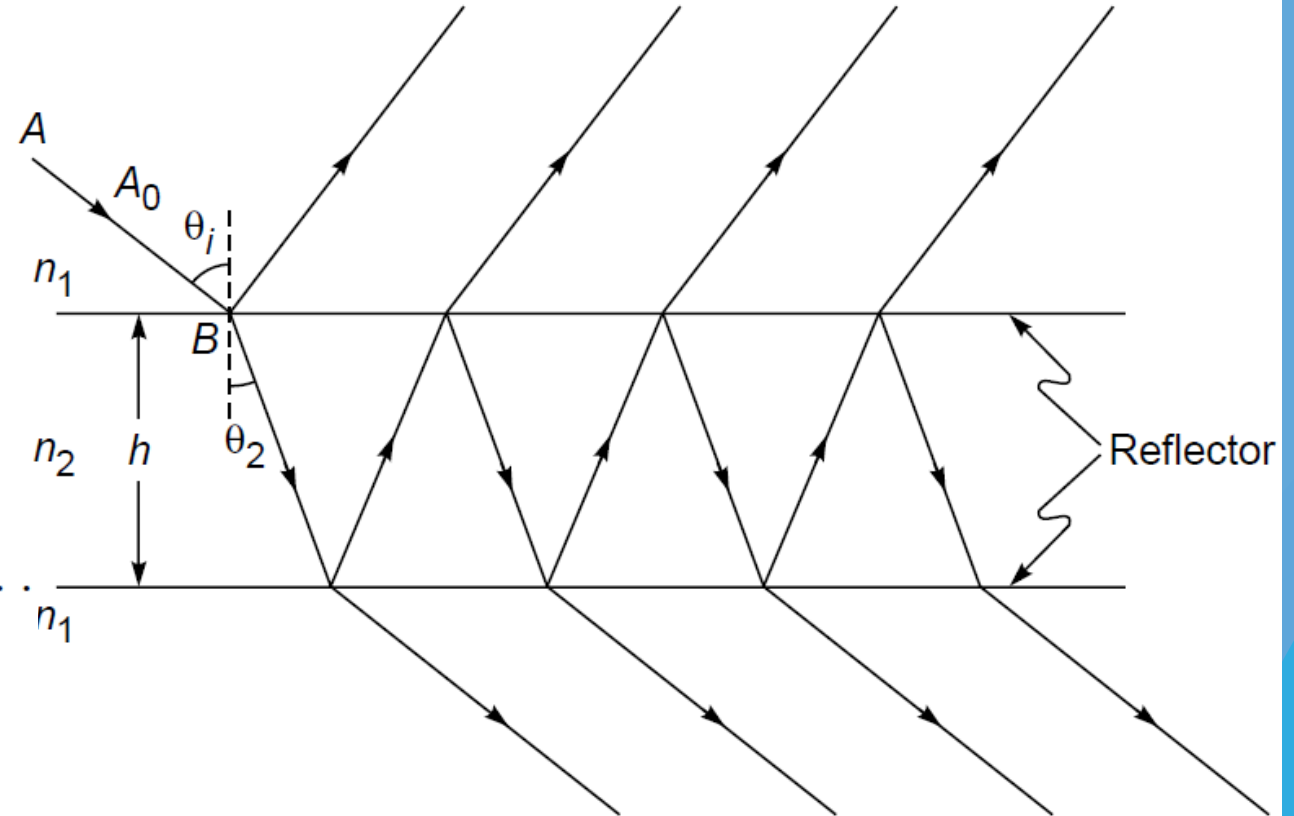
Multiple reflections from a plane parallel film

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where $\delta = \frac{2\pi}{\lambda_0} \Delta = \frac{4\pi n_2 h \cos \theta_2}{\lambda_0}$

represents the phase difference (between two successive waves emanating from the plate) due to the additional path traversed by the beam in the film



$$A_r = A_0 [r_1 + t_1 t_2 r_2 e^{i\delta} (1 + r_2^2 e^{i\delta} + r_2^4 e^{2i\delta} + \dots)]$$

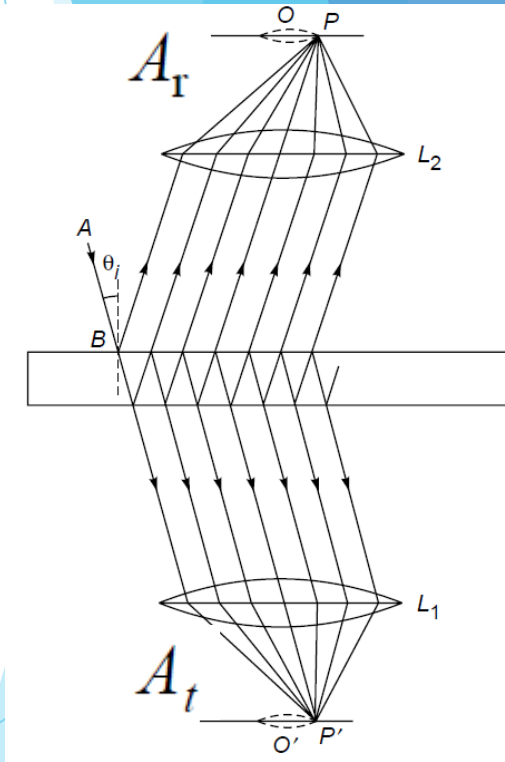
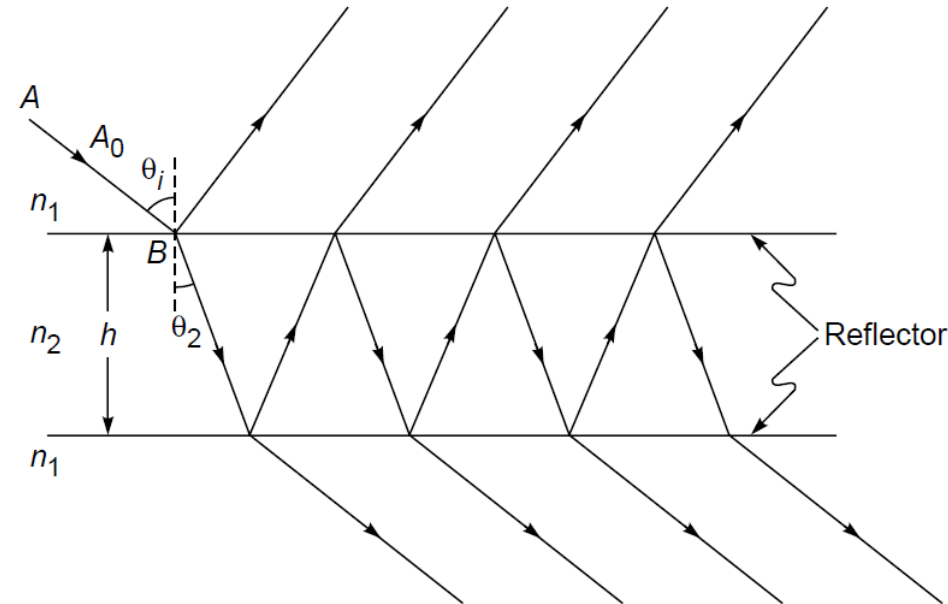
$$= A_0 \left(r_1 + \frac{t_1 t_2 r_2 e^{i\delta}}{1 - r_2^2 e^{i\delta}} \right) \quad \text{resultant amplitude of the reflected wave}$$

Resultant amplitude of reflected wave

$$A_r = A_0[r_1 + t_1 t_2 r_2 e^{i\delta} (1 + r_2^2 e^{i\delta} + r_2^4 e^{2i\delta} + \dots)]$$

$$= A_0 \left(r_1 + \frac{t_1 t_2 r_2 e^{i\delta}}{1 - r_2^2 e^{i\delta}} \right)$$

$$\boxed{\frac{A_r}{A_0} = r_1 \left[1 - \frac{(1 - R)e^{i\delta}}{1 - Re^{i\delta}} \right]}$$

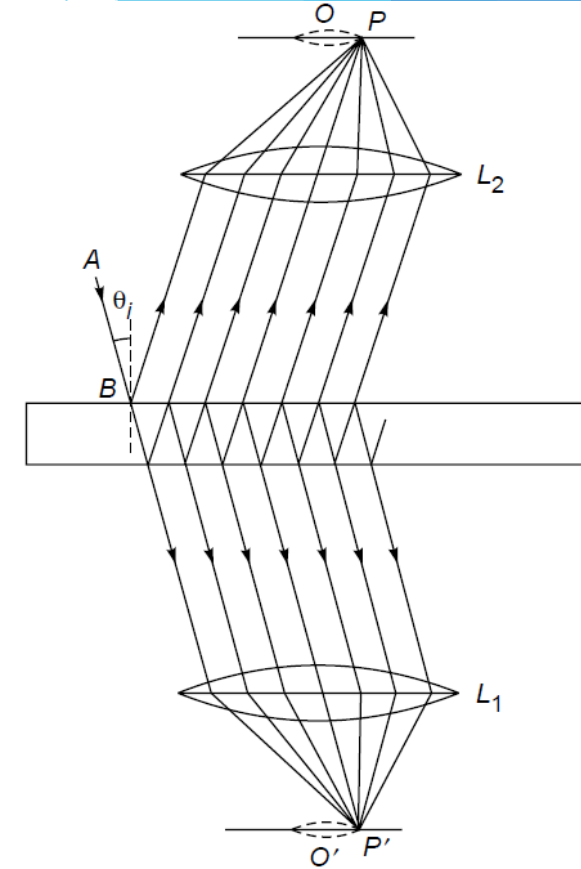
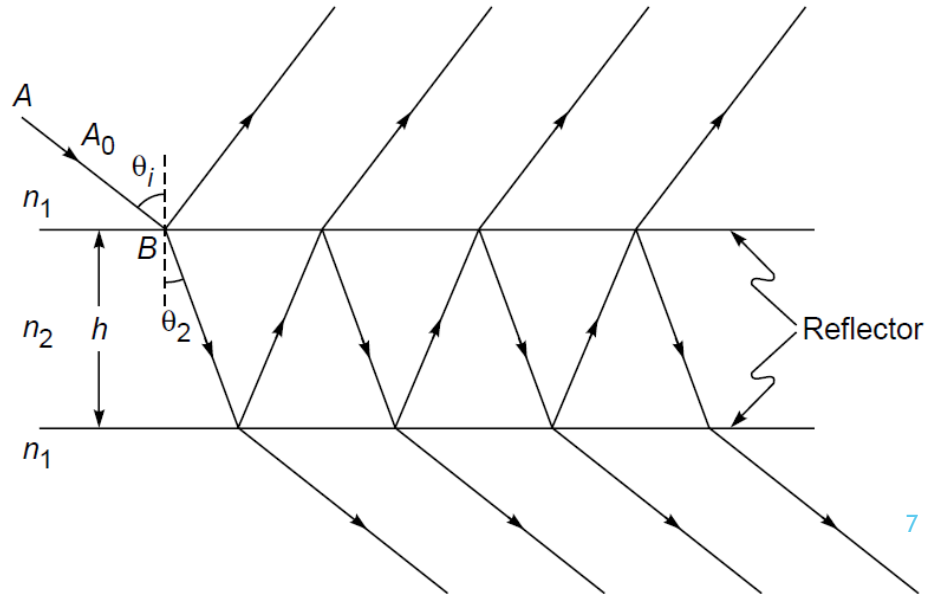


Resultant amplitude of transmitted wave

resultant amplitude of the transmitted wave

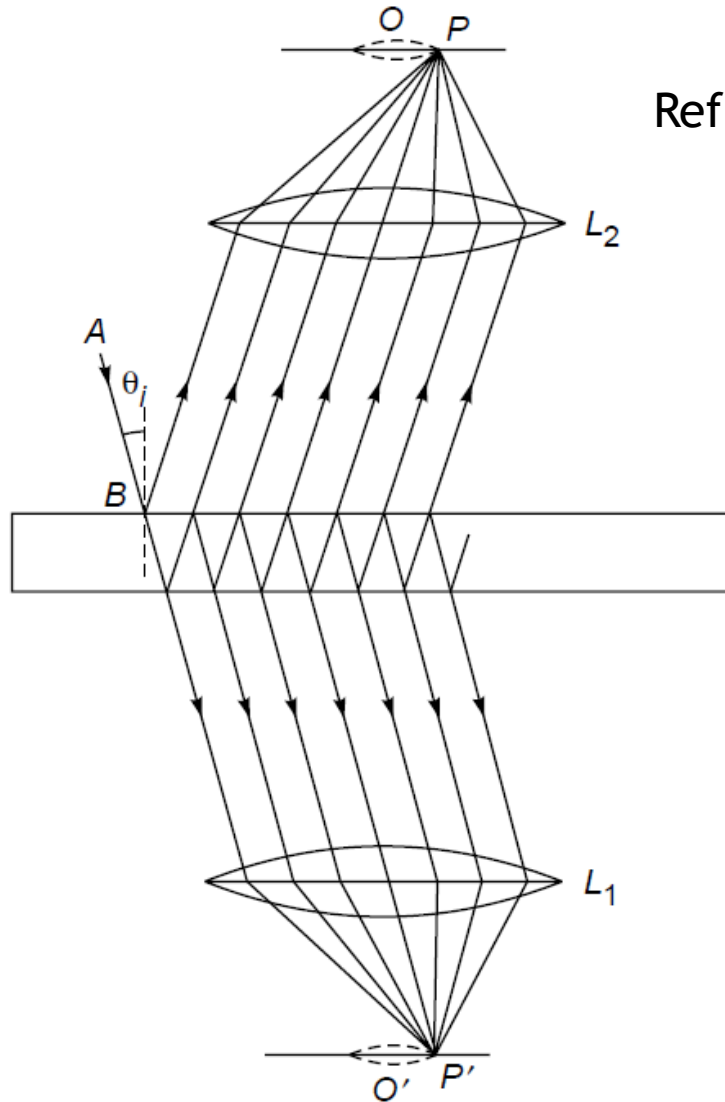
$$A_t = A_0 t_1 t_2 (1 + r_2^2 e^{i\delta} + r_2^4 e^{2i\delta} + \dots)$$

$$= A_0 \frac{t_1 t_2}{1 - r_2^2 e^{i\delta}} = A_0 \frac{1 - R}{1 - R e^{i\delta}}$$



Reflectivity of the instrument using the interface

$$\begin{aligned} \mathcal{R} &= \left| \frac{A_r}{A_0} \right|^2 = R \left| \frac{1 - e^{i\delta}}{1 - R e^{i\delta}} \right|^2 \\ &= R \frac{(1 - \cos \delta)^2 + \sin^2 \delta}{(1 - R \cos \delta)^2 + R^2 \sin^2 \delta} \\ &= \frac{4R \sin^2 \delta/2}{(1 - R)^2 + 4R \sin^2 \delta/2} \\ \mathcal{R} &= \frac{F \sin^2 \delta/2}{1 + F \sin^2 \delta/2} \end{aligned}$$



Reflectivity of the given interface

$$R = r_1^2 = r_2^2$$

$$\tau = t_1 t_2 = 1 - R$$

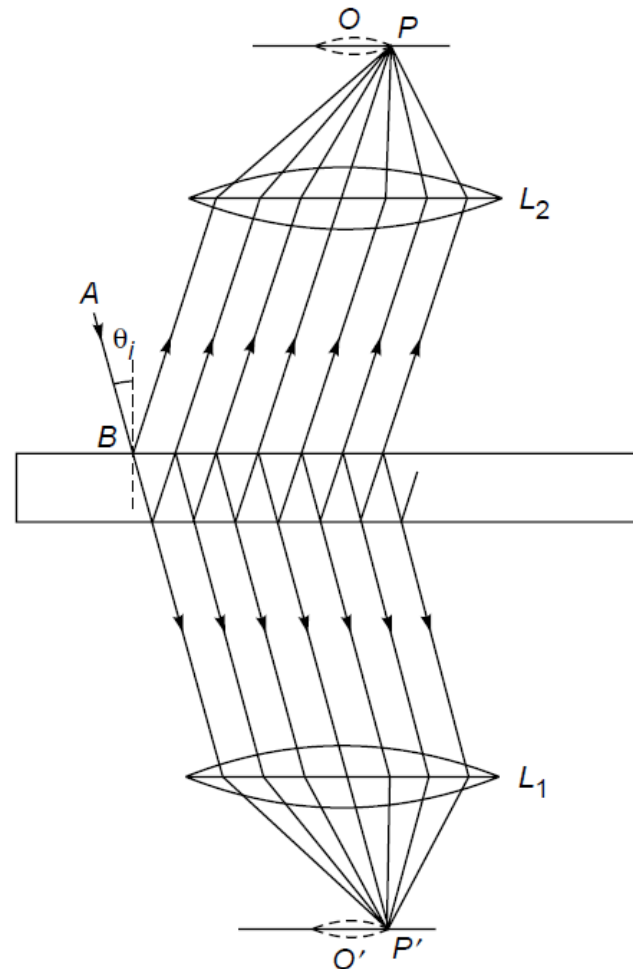
F=Coefficient of Finesse

$$\begin{aligned} T &= \left| \frac{A_t}{A_0} \right|^2 = \frac{(1 - R)^2}{(1 - R \cos \delta)^2 + R^2 \sin^2 \delta} \\ T &= \frac{1}{1 + F \sin^2 \delta/2} \end{aligned}$$

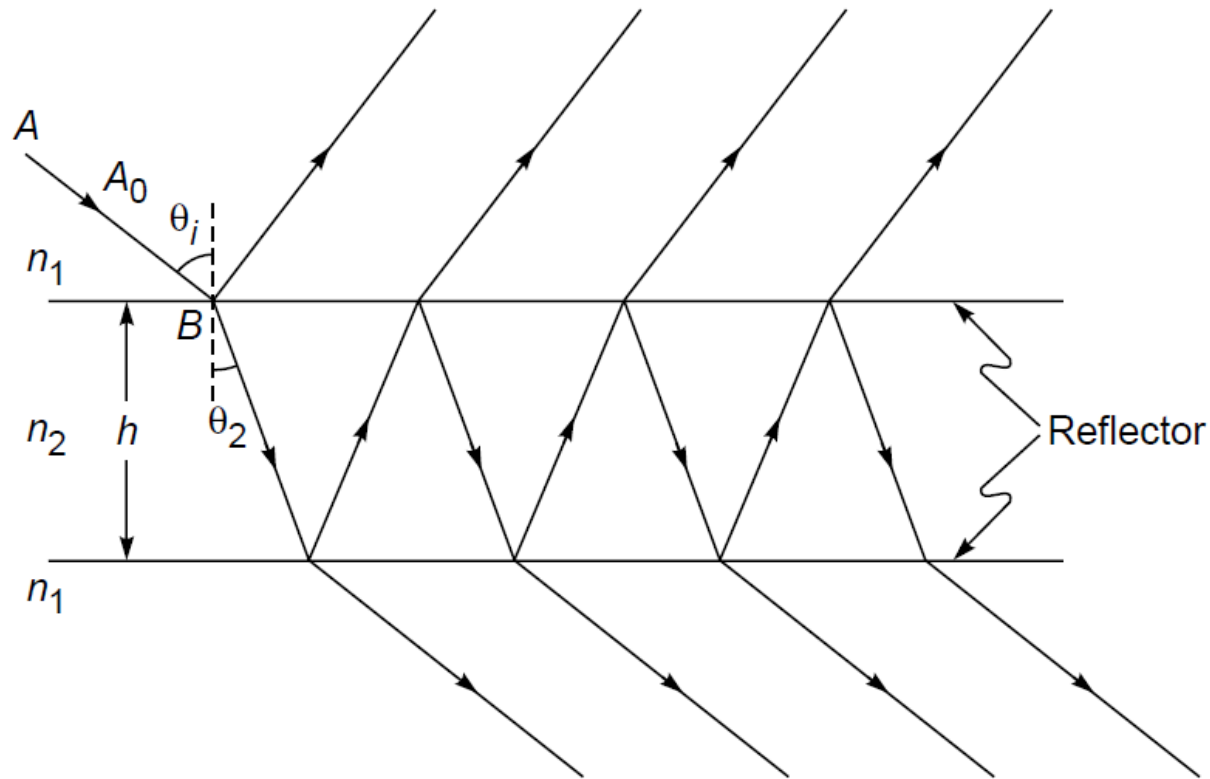
Multiple reflections from a plane parallel film

Any ray parallel to AB will focus at the same point P. If ray AB is rotated about the normal at B, then point P will rotate on the circumference of a circle centered at point O; this circle will be bright or dark depending on the value of θ_i .

Rays incident at different angles will focus at different distances from point O, and one will obtain concentric bright and dark rings for an extended source.



Multiple reflections from a plane parallel film



Q: Do R and τ give any hint about single/multiple reflection?

What else do you need for multiple reflection?

(1) We've 2 media (say air-glass/ air-diamond/ water-glass etc.).
2 different media \rightarrow hence 2 different r.i. (n_1, n_2)

(2) For a particular interface/pair (air-glass/water-glass etc.) reflection coefficient

$$r = \frac{(n_1 - n_2)^2}{(n_1 + n_2)^2}$$

For upper and lower surfaces $r_1 = -r_2$

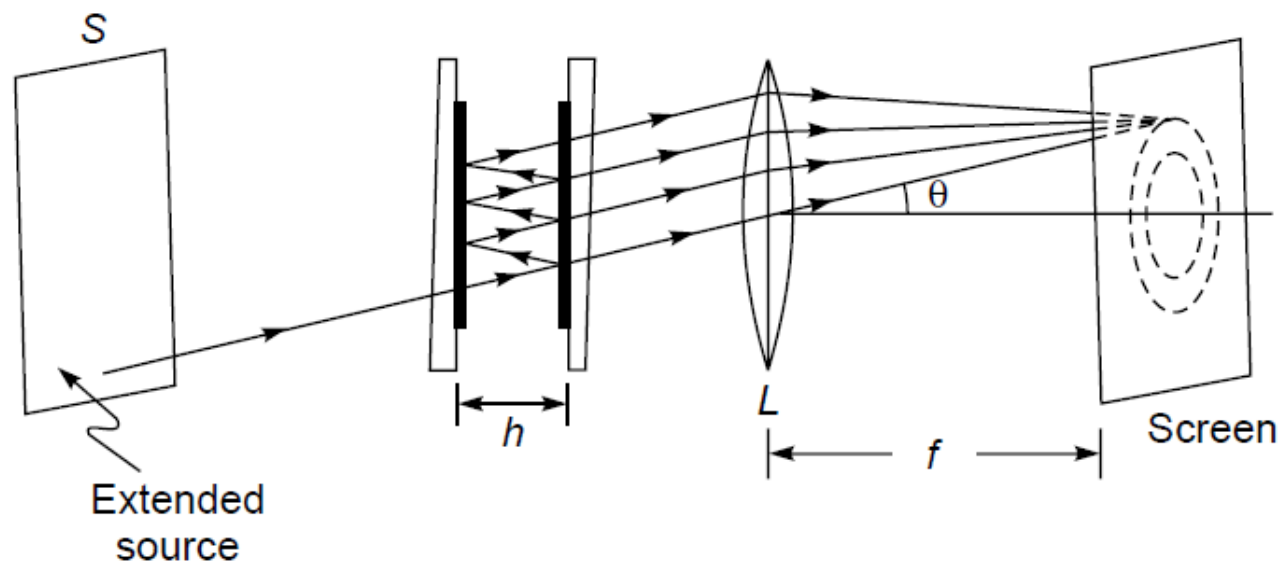
(3) For that particular interface:

Reflectivity $R = r^2$

Transmittivity $\tau = 1 - R$

(4) Generally $T \rightarrow$ here τ to avoid confusion between transmittivity for a given interface and transmittivity of a device having multiple reflection and transmission

Fabry-Perot interferometer



Transmittivity of the instrument (not $\tau \rightarrow$ property of the 2 media forming interface)

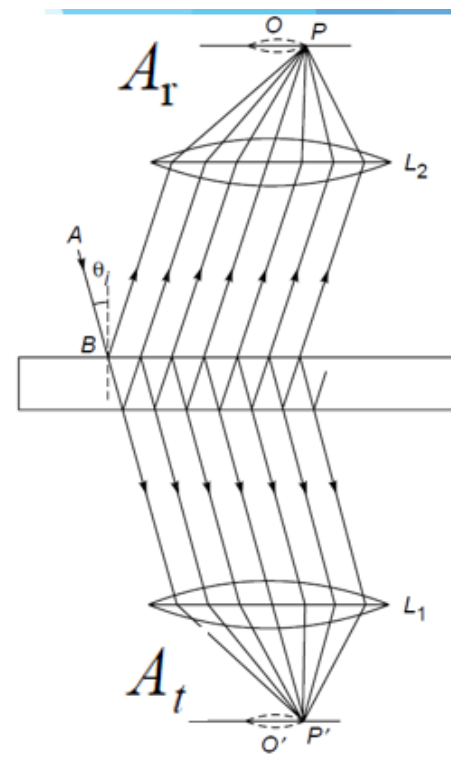
$$T = \left| \frac{A_t}{A_0} \right|^2 = \frac{(1-R)^2}{(1-R \cos \delta)^2 + R^2 \sin^2 \delta}$$

Reflectivity of the instrument

$$\mathcal{R} = \left| \frac{A_r}{A_0} \right|^2 = R \left| \frac{1 - e^{i\delta}}{1 - R e^{i\delta}} \right|^2$$

$$= R \frac{(1 - \cos \delta)^2 + \sin^2 \delta}{(1 - R \cos \delta)^2 + R^2 \sin^2 \delta}$$

$$= \frac{4R \sin^2 \delta/2}{(1-R)^2 + 4R \sin^2 \delta/2}$$



Problem:1

Consider a monochromatic beam of wavelength 6000 \AA incident (from an extended source) on a Fabry–Perot etalon with $n_2 = 1$, $h = 1 \text{ cm}$, and $F = 200$. Concentric rings are observed on the focal plane of a lens of focal length 20 cm . Calculate the reflectivity of each mirror.

Answer:

$$F = \frac{4R}{(1-R)^2} \Rightarrow \begin{aligned} 200 &= \frac{4R}{(1-R)^2} \\ 50 &= \frac{R}{(1+R^2-2R)} \end{aligned}$$

$$50 + 50R^2 - 100R = R$$

$$50R^2 - 101R + 50 = 0$$

By solving above quadratic equation,

$$R = 1.15 \text{ or } 0.87$$

$R=0.87$ (Since R will be less than 1)

Thank You